

N-channel TrenchMOS logic level FET 13 February 2014

Product data sheet

#### **General description** 1.

Logic level N-channel MOSFET in a SOT404 package using TrenchMOS technology. This product has been designed and gualified to AEC Q101 standard for use in high performance automotive applications.

#### 2. Features and benefits

- AEC Q101 compliant •
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating •
- True logic level gate with Vgst(th) rating of greater than 0.5V at 175 °C •

#### **Applications** 3.

- 12V, 24V and 48V Automotive systems
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control •
- Ultra high performance power switching

#### Quick reference data 4.

Table 1. Quid	ck reference data					-			
Symbol	Parameter	Conditions		Min	Тур	Max	Unit		
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	100	V		
I <sub>D</sub>	drain current	V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	-	66	А		
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 3</u>		-	-	182	W		
Static characte	eristics								
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 5 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>		-	12.5	15	mΩ		
Dynamic characteristics									
Q <sub>GD</sub>	gate-drain charge	V <sub>GS</sub> = 5 V; I <sub>D</sub> = 15 A; V <sub>DS</sub> = 80 V; Fig. 13; Fig. 14		-	23	-	nC		





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## 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain		
3	S	source		G-UFA
mb	D	mounting base; connected to drain	D2PAK (SOT404)	mbb076 S

# 6. Ordering information

Table 3. Ordering information									
Type number	Package								
	Name	Description	Version						
BUK9615-100E	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404						

## 7. Marking

Table 4. Marking codes	
Type number	Marking code
BUK9615-100E	BUK9615-100E

# 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 ##C; T <sub>j</sub> ≤ 175 °C		-	100	V
V <sub>DGR</sub>	drain-gate voltage	R <sub>GS</sub> = 20 kΩ		-	100	V
V <sub>GS</sub>	gate-source voltage	T <sub>j</sub> ≤ 175 °C; DC		-10	10	V
		$T_j \le 175 \text{ °C}; \text{ Pulsed}$	[1][2]	-15	15	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 5 V; <u>Fig. 1</u>		-	66	А
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 5 V; <u>Fig. 1</u>		-	47	А
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 2		-	266	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 3</u>		-	182	W
T <sub>stg</sub>	storage temperature			-55	175	°C
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# **BUK9615-100E**

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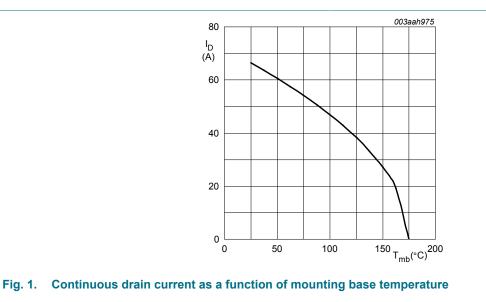
Symbol	Parameter	Conditions		Min	Мах	Unit			
Tj	junction temperature			-55	175	°C			
Source-drain	diode		1						
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C		-	66	А			
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^\circ C$		-	266	А			
Avalanche ru	Avalanche ruggedness								
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\label{eq:ID} \begin{split} I_D &= 66 \text{ A};  \text{V}_{sup} \leq 100  \text{V};  \text{R}_{GS} = 50  \Omega; \\  \text{V}_{GS} &= 5  \text{V};  \text{T}_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped}; \\ \hline \text{Fig. 4} \end{split}$	[3][4]	-	132	mJ			

Accumulated pulse duration up to 50 hours delivers zero defect ppm [1]

[2]

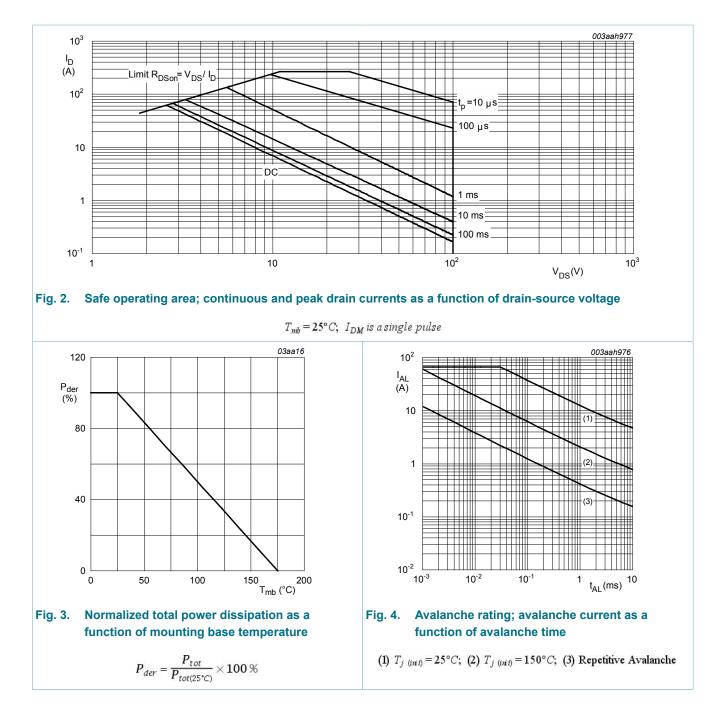
Significantly longer life times are achieved by lowering  $T_j$  and or  $V_{GS}$ Single-pulse avalanche rating limited by maximum junction temperature of 175 °C. Refer to application note AN10273 for further information.

[3] [4]



 $V_{GS} \ge 5V$ 

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## 9. Thermal characteristics

Table 6. The	rmal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	0.82	K/W

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Symbol	Parameter	Conditions	5			Min	Тур	Мах	Unit
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient		minimum footprint ; mounted on a printed-circuit board		-		50	-	K/W
1 $\overline{c} = 0$ $\overline{c} = 0$ 								03aah708	
10 <sup>-2</sup>						P		$\overline{\delta} = \frac{t_p}{T}$	
10 <sup>-3</sup>	10 <sup>-5</sup>	10 <sup>-4</sup>	10-3	10 <sup>-2</sup>		10 <sup>-1</sup>	t <sub>p</sub>  ←  ← T → t <sub>p</sub> (s	<b>i b b b c c c c c c c c c c</b>	

# **10. Characteristics**

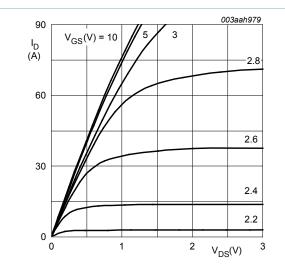
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	octeristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C	100	-	-	V
	breakdown voltage	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C	90	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 25 °C; Fig. 9; Fig. 10	1.4	1.7	2.1	V
		$I_D = 1 \text{ mA; } V_{DS} = V_{GS}; T_j = -55 \text{ °C;}$ Fig. 9	-	-	2.45	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; Fig. 9	0.5	-	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 100 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.04	1	μA
		V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C	-	-	500	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 10 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
		$V_{GS}$ = -10 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state	$V_{GS}$ = 5 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 25 °C; Fig. 11	-	12.5	15	mΩ
	resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 25 °C; Fig. 11	-	12	14	mΩ

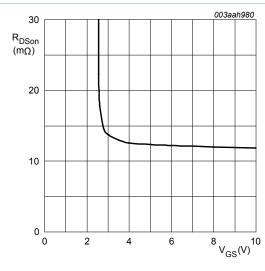
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		V <sub>GS</sub> = 5 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 175 °C; <u>Fig. 12; Fig. 11</u>	-	-	41	mΩ
Dynamic c	haracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D$ = 15 A; $V_{DS}$ = 80 V; $V_{GS}$ = 5 V;	-	60	-	nC
Q <sub>GS</sub>	gate-source charge	<u>Fig. 13; Fig. 14</u>	-	11	-	nC
Q <sub>GD</sub>	gate-drain charge		-	23	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; <sup>−</sup> <sub>j</sub> = 25 °C; <u>Fig. 15</u>	-	5110	6813	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; <u>Fig. 15</u>	_	307	368	pF
C <sub>rss</sub>	reverse transfer capacitance	-	-	202	277	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 80 V; R <sub>L</sub> = 5 Ω; V <sub>GS</sub> = 5 V; R <sub>G(ext)</sub> = 5 Ω	-	26.6	-	ns
t <sub>r</sub>	rise time		-	62.2	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	77.6	-	ns
t <sub>f</sub>	fall time	_	-	59.1	-	ns
L <sub>D</sub>	internal drain inductance	from upper edge of drain mounting base to center of die	-	2.5	-	nH
L <sub>S</sub>	internal source inductance	from source lead to source bonding pad	-	7.5	-	nH
Source-dra	in diode		I			
V <sub>SD</sub>	source-drain voltage	$I_{S}$ = 15 A; $V_{GS}$ = 0 V; $T_{j}$ = 25 °C; <u>Fig. 16</u>	-	0.8	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S}$ = 15 A; d $I_{S}$ /dt = -100 A/µs; $V_{GS}$ = 0 V;	-	51	-	ns
Qr	recovered charge	V <sub>DS</sub> = 25 V	-	115	-	nC





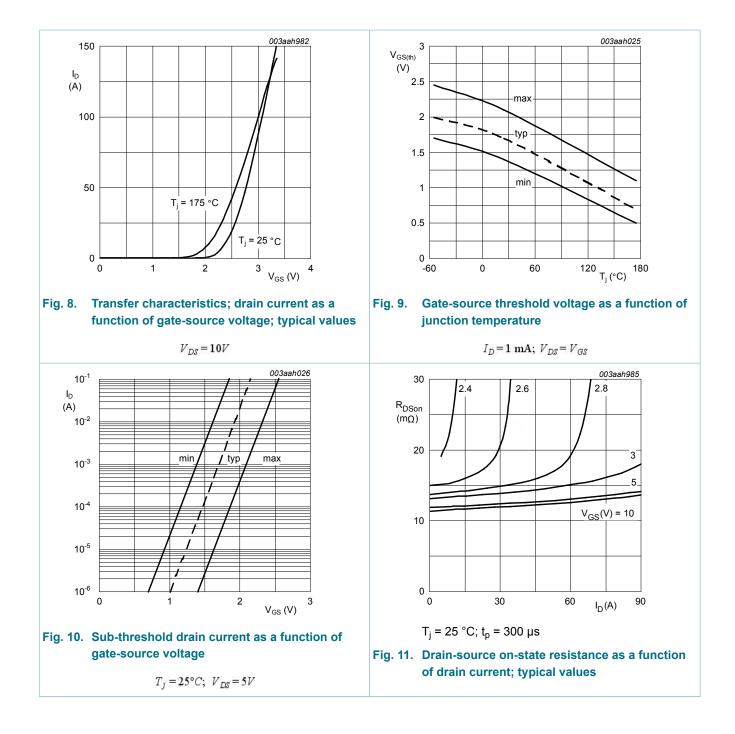




 $T_j = 25^{\circ}C; I_D = 15A$ 

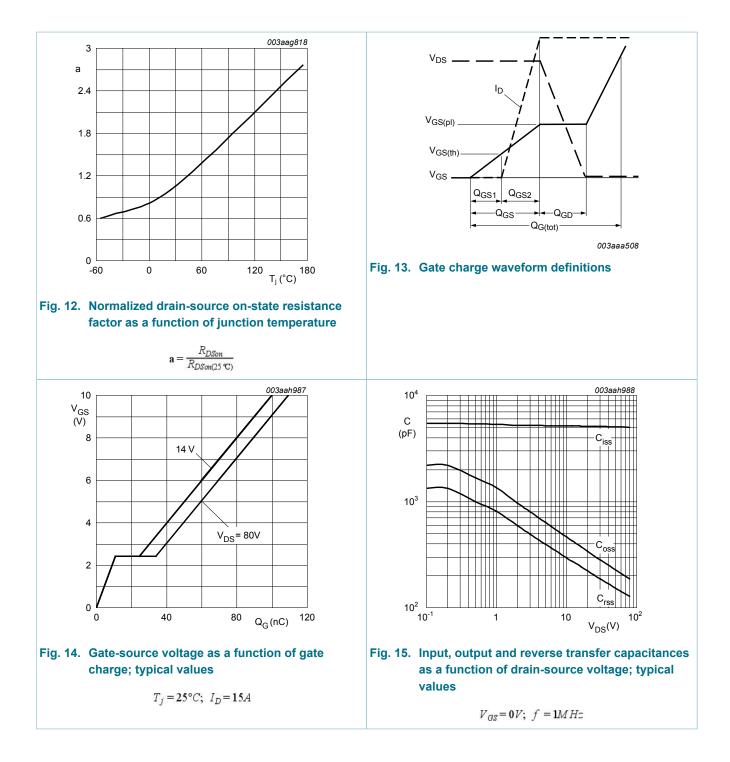
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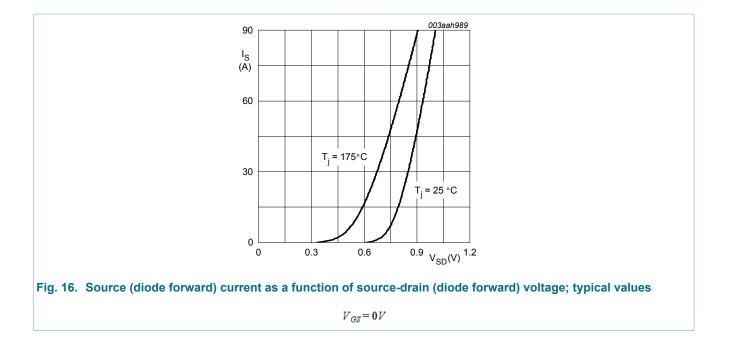
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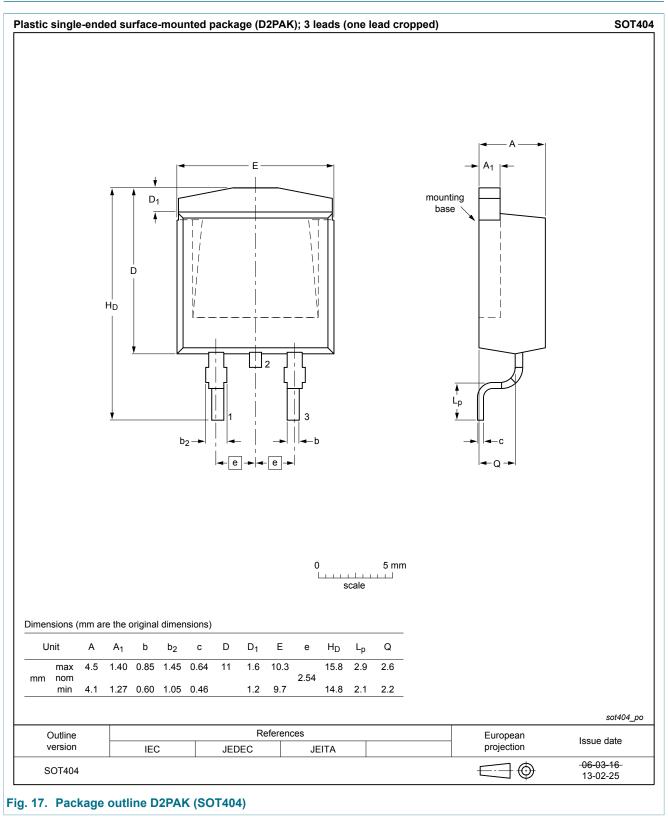
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### 11. Package outline



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Document status [1][2]	Product status [ <u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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